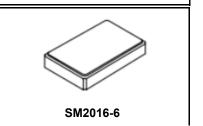


PRELIMINARY



XTC7057H

40.000 MHz TCXO



Features:

- Ultra Miniature SMD Package
- Good Frequency Stability
- Good Phase Noise Response
- Moisture Sensitivity Level (MSL): Level-1
- AEC-Q200 (IC: AEC-Q100) compliance

Description and Applications:

Surface mount 2.0mmx1.6mm TCXO for use in wireless communications devices

Electrical Specifications:

LH7+\$)+<	Specifications
Nominal Frequency, Fo	40.000 MHz
Storage Temperature Range	-40°C to +85°C
Operating Temperature Range	-40°C to +85°C
Power Supply Voltage, Vcc	2.7~3.6 V (Nominal 3.3V)
Output Waveform	Clipped Sinewave
Output Voltage with Load 10pF//10KΩ, Vout	0.8 Vp-p min
Power Supply Current, Icc	2.0 mA max
Frequency Tolerance as Received Ref. to Nominal Frequency	+/- 1.0 ppm max @ 25°C +/- 3°C
Frequency Deviation after 2 x Reflow Ref. to pre-reflow Freq.	+/- 1.0 ppm max @ 25°C +/- 3°C
Frequency Stability a. Vs. Temperature (-30~85°C)	+/- 0.5 ppm reference to the middle point between minimum and maximum frequency value +/- 1.0 ppm reference to the middle point between
b. Vs. Temperature (-40~-30°C)	minimum and maximum frequency value
c. Vs. Load varied 10pF//10KΩ+/-10%d. Vs. Supply Voltage varied Vcc+/-5%	+/- 0.2 ppm +/- 0.2 ppm
Start Up Time (90% of final RF level in Vp-p)	2.0 msec max.
Aging	+/-1.0 ppm/ first year @25°C +/-5.0 ppm/ 10 years @25°C
Harmonics	-5.0 dBc max

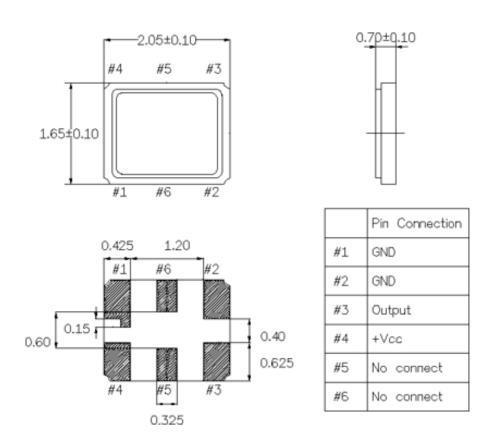
SSB Phase Noise	(@1Hz Carrier Offset)	-55 dBc/Hz max
SSB Phase Noise	(@10Hz Carrier Offset)	-87 dBc/Hz max
SSB Phase Noise	(@100Hz Carrier Offset)	-112 dBc/Hz max
SSB Phase Noise	(@1KHz Carrier Offset)	-134 dBc/Hz max
SSB Phase Noise	(@10KHz Carrier Offset)	-153 dBc/Hz max
SSB Phase Noise	(@100KHz Carrier Offset)	-157 dBc/Hz max
SSB Phase Noise	(@1MHz Carrier Offset)	-157 dBc/Hz max
Marking		Laser marking

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CAUTION: Electrostatic Sensitive Device. Observe precautions for handling. NOTES:

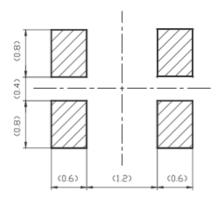
- 1. The design, manufacturing process, and specifications of this device are subject to change.
- 2. US or International patents may apply.
- 3. RoHS compliant from the first date of manufacture.

Mechanical Dimensions (mm):

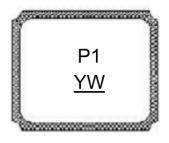


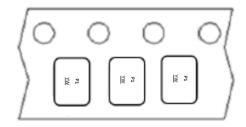
Note: This package has two extra pads in the middle (pin #5 and #6) that are used to test the internal Xtal by the factory, but are not intended for customer use. Do not place ground (GND) patterns (including ground pads, via holes, etc.) under the crystal unit, especially under pin #5 and #6. Also, do not run RF signal power or digital line under the package in the multi-layered PCB.

Recommended Land Pattern: (unit: mm)

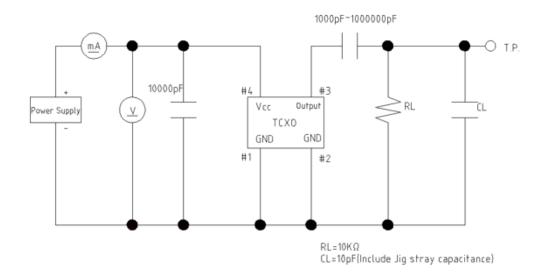


Marking Y = Year, W = Week



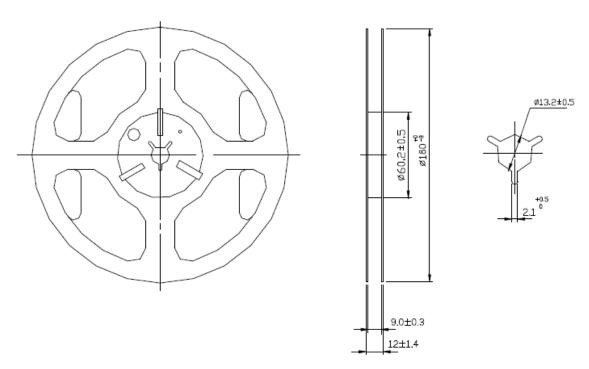


Recommended Circuit

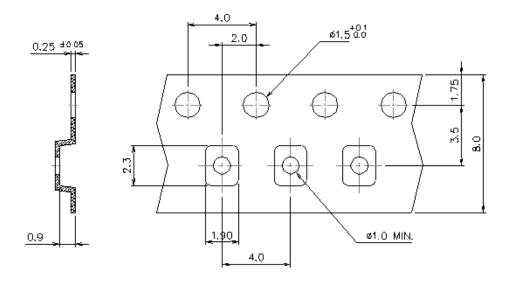


Reel Dimension

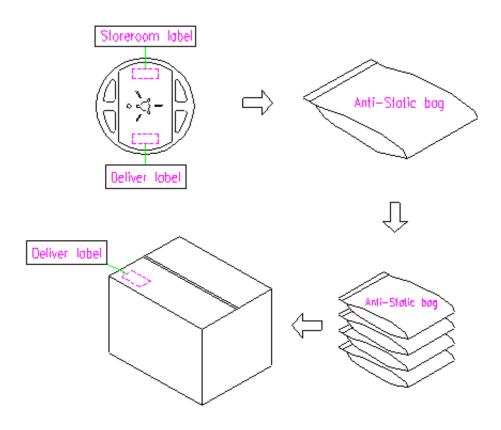
Reel Count: 7" = 3000



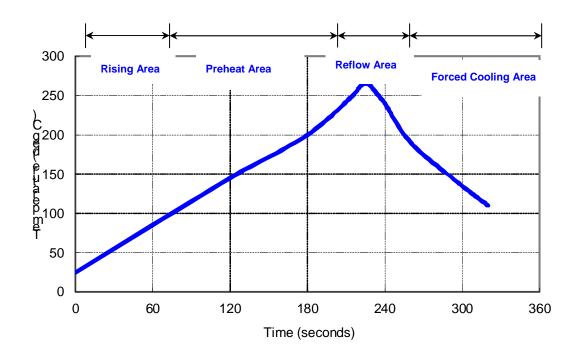
Tape Dimension



Packing Quantity/Packing: 3K pcs maximum per reel



Reflow Profile:



Notes of the Usage:

- 1. Touch the solder iron at 260+/-5 deg C onto the leads for 10+/-2 sec max or touch the solder at 350+/-5 deg C onto the leads for 3+/-0.5 sec.
- 2. In the customer's reflow process, if it will remain some mechanical stress at the soldering terminals, also make some cracks on the soldering termination. Some cracks will cause open or short circuit and cause of thermal increasing or smoking. Don't make any excess mechanical stress to soldering points.
- 3. In case of giving a heavy shock to the products, it may make an open or short circuit and cause of thermal increasing and smoking. To avoid heavy shock impact applying to products is strictly required.
- 4. Ultrasonic cleaning should be avoided to prevent damage to the TCXO.
- 5. Do Not Use Ultrasonic-Wave Soldering or Wave Solder with Package Immersed in Solder.
- 6. Do not lay out the ground (GND) pattern under crystal unit, this will add parasitic capacitance.
- 7. Do not run Digital / RF signal lines, power, or ground under oscillators for multi-layered PCB, as this will add noise.

Notes of the Storage:

- 1. To keep products under the condition at the room temperature (-5~35 deg C) with normal humidity (45~75%). Absorption of moisture and dewdrop may make inferiority of characteristics and a short circuit.
- 2. Oxidization of terminals shall make the solderability more inferior. Dusts and corrosive gas will make a cause of the open or short circuit. Keep it in the clean place where is not in dusty and no corrosive gas.
- 3. Use the anti-static material to the storage package.
- 4. Don't put any excess weight to the TCXO in the storage process.
- 5. Don't move the product from the cold place to the hot place in the short time, otherwise it may make some dew-drop, then a short circuit may happen in case.
- 6. Storage periods should be maximum 6 months under condition of above item 1 after delivery from the factory.
- 7. Once open the bag, there is possibility of electrical characteristics deterioration due to absorption of moisture. So, please use parts within 7 days after opening the bag.
- 8. If you have to keep parts without using after opening the bag, please put the drying agent in the bag, fold the bag and keep it in the place where temperature and humidity are controlled (nitrogen atmosphere box etc.)

Reliability Specifications (AEC-Q200)

Test name	Test process / method	Reference standard			
Mechanical cha	Mechanical characteristics				
resistance to Soldering heat (IR reflow)	Temp./ Duration: 265℃ /10sec ×2 times Total time: 4min.(IR-reflow)	-300(301)M(II)			
Vibration	Total peak amplitude : 1.5mm Vibration frequency : 10 to 2000 Hz Sweep period : 20 minute Vibration directions : 3 mutually perpendicular	MIL-STD 202G method 204			
Mechanical Shock	directions: 3 impacts per axis Acceleration: 6000g's, +20/-0 % Duration: 0.3 ms (total 18 shocks) Waveform: Half-sine	MIL-STD 202G method 213			
Solderability	Solder Temperature:265±5℃ Duration time: 5±0.5 seconds.	J-STD-002			
Environmental characteristics					
Thermal Shock	Heat cycle conditions -55 $^{\circ}$ C (30min) \longleftrightarrow 125 $^{\circ}$ C (30min) * cycle time : 1000 times	MIL-STD 883G method 1010.8			
Humidity test	Temperature : 85 ± 2 ℃ Relative humidity : 85% Duration : 1000 hours	MIL-STD 202G method 103			
Dry heat (Aging test)	Temperature : 125 ± 2 ℃ Duration : 1000 hours	MIL-STD 202G method 108A			
	Temperature : -40 ± 3 ℃ Duration : 1000 hours	IEC 60068-2-1			